AOT66916L/AOB66916L

ALPHA & OMEGA SEMICONDUCTOR

100V N-Channel AlphaSGT™

General Description

- Trench Power AlphaSGT™ technology
- Best in class on-resistance $R_{DS(ON)}$
- Lowers switching loss by lower Qrr than other MOSFET suppliers
- Optimized voltage spike at SSR application
- RoHS and Halogen-Free Compliant

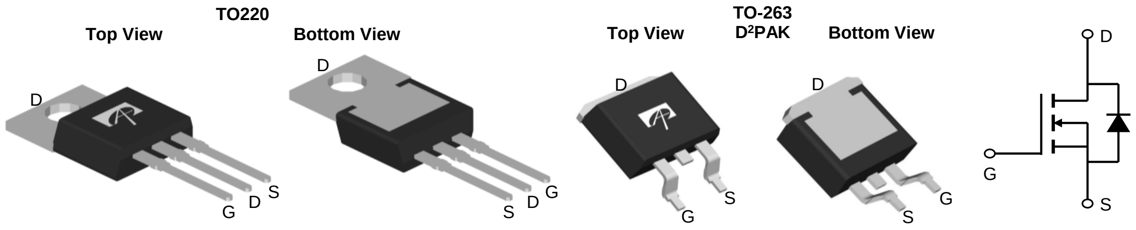
Applications

- High frequency switching and synchronous rectification
- BMS
- Motor

Product Summary

V_{DS}	100V
I_D (at V_{GS}=10V)	120A
$R_{DS(ON)}$ (at V_{GS}=10V)	< 3.6mΩ
$R_{DS(ON)}$ (at V_{GS}=6V)	< 4.8mΩ

100% UIS Tested
100% Rg Tested



AOT66916L AOB66916L

Orderable Part Number	Package Type	Form	Minimum Order Quantity
AOT66916L	TO-220	Tube	1000
AOB66916L	TO-263	Tape & Reel	800

Absolute Maximum Ratings T_A=25°C unless otherwise noted

Parameter		Symbol	Maximum	Units
Drain-Source Voltage		V_{DS}	100	V
Gate-Source Voltage		V_{GS}	±20	V
Continuous Drain Current [G]	T_C=25°C	I_D	120	A
	T_C=100°C		120	
Pulsed Drain Current [C]		I_{DM}	450	
Continuous Drain Current	T_A=25°C	I_{DSM}	35.5	A
	T_A=70°C		28.5	
Avalanche Current [C]		I_{AS}	80	A
Avalanche energy	L=0.1mH [C]	E_{AS}	320	mJ
Power Dissipation [B]	T_C=25°C	P_D	277	W
	T_C=100°C		111	
Power Dissipation [A]	T_A=25°C	P_{DSM}	8.3	W
	T_A=70°C		5.3	
Junction and Storage Temperature Range		T_J, T_{STG}	-55 to 150	°C

Thermal Characteristics

Parameter		Symbol	Typ	Max	Units
Maximum Junction-to-Ambient [A]	t ≤ 10s	$R_{\theta JA}$	12	15	°C/W
Maximum Junction-to-Ambient [A D]	Steady-State		50	60	°C/W
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	0.35	0.45	°C/W

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Typ	Max	Units
STATIC PARAMETERS							
BV_{DSS}	Drain-Source Breakdown Voltage	I_D=250µA, V_{GS}=0V		100			V
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS}=100V, V_{GS}=0V				1	µA
			T_J=55°C			5	
I_{GSS}	Gate-Body leakage current	V_{DS}=0V, V_{GS}=±20V				±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS}=$V_{GS,}$ I_D=250µA		2.5	2.95	3.5	V
$R_{DS(ON)}$	Static Drain-Source On-Resistance	V_{GS}=10V, I_D=20A			3.0	3.6	mΩ
			T_J=125°C		4.9	5.9	
		V_{GS}=6V, I_D=20A			3.6	4.8	mΩ
g_{FS}	Forward Transconductance	V_{DS}=5V, I_D=20A			80		S
V_{SD}	Diode Forward Voltage	I_S=1A, V_{GS}=0V			0.68	1	V
I_S	Maximum Body-Diode Continuous Current [G]					120	A
DYNAMIC PARAMETERS							
C_{iss}	Input Capacitance	V_{GS}=0V, V_{DS}=50V, f=1MHz			6180		pF
C_{oss}	Output Capacitance				1660		pF
C_{rss}	Reverse Transfer Capacitance				29		pF
R_g	Gate resistance	f=1MHz		0.7	1.5	2.3	Ω
SWITCHING PARAMETERS							
Q_g(10V)	Total Gate Charge	V_{GS}=10V, V_{DS}=50V, I_D=20A			78		nC
Q_{gs}	Gate Source Charge				22		nC
Q_{gd}	Gate Drain Charge				15		nC
Q_{oss}	Output Charge	V_{GS}=0V, V_{DS}=50V			134		nC
$t_{D(on)}$	Turn-On DelayTime	V_{GS}=10V, V_{DS}=50V, R_L=2.5Ω, R_{GEN}=3Ω			24		ns
t_r	Turn-On Rise Time				18		ns
$t_{D(off)}$	Turn-Off DelayTime				52		ns
t_f	Turn-Off Fall Time				22		ns
t_{rr}	Body Diode Reverse Recovery Time	I_F=20A, di/dt=500A/µs			45		ns
Q_{rr}	Body Diode Reverse Recovery Charge	I_F=20A, di/dt=500A/µs			287		nC

A. The value of $R_{\theta JA}$ is measured with the device mounted on 1in^2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The Power dissipation P_{DSM} is based on R $_{\theta JA}$ t≤ 10s and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.
B. The power dissipation P_D is based on $T_{J(MAX)}$=150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
C. Single pulse width limited by junction temperature $T_{J(MAX)}$=150° C.
D. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient.
E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}$=150° C. The SOA curve provides a single pulse rating.
G. The maximum current rating is package limited.
H. These tests are performed with the device mounted on 1 in^2 FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C.

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

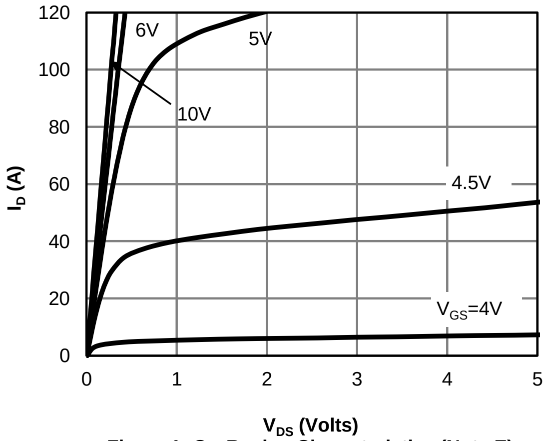


Figure 1: On-Region Characteristics (Note E)

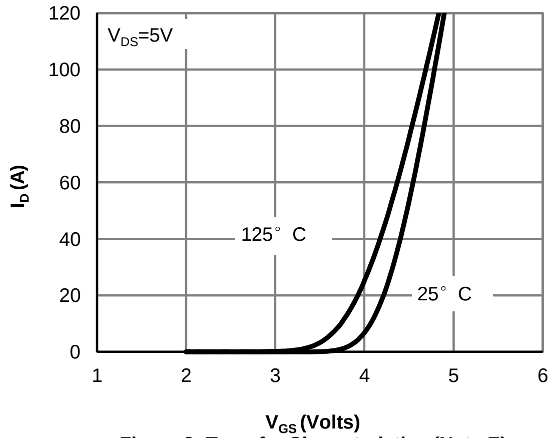


Figure 2: Transfer Characteristics (Note E)

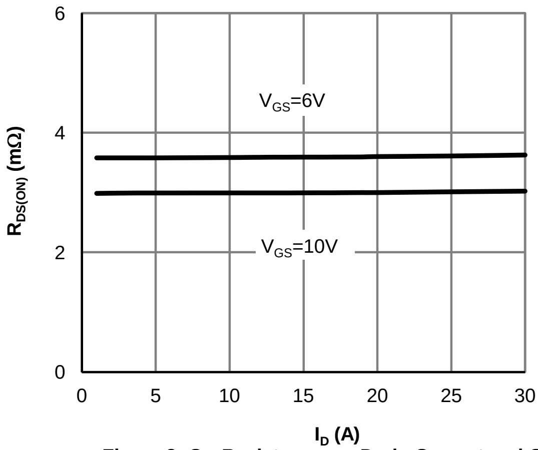


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

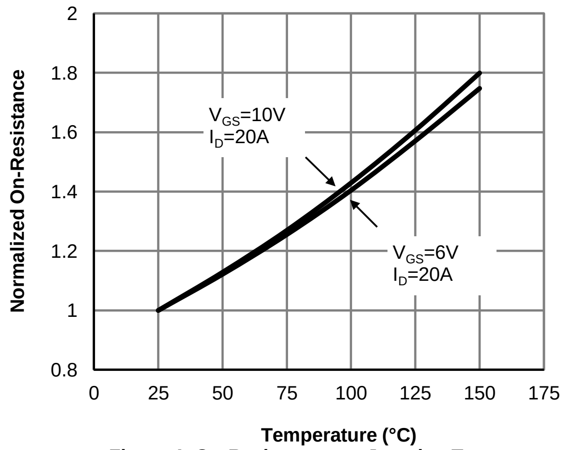


Figure 4: On-Resistance vs. Junction Temperature (Note E)

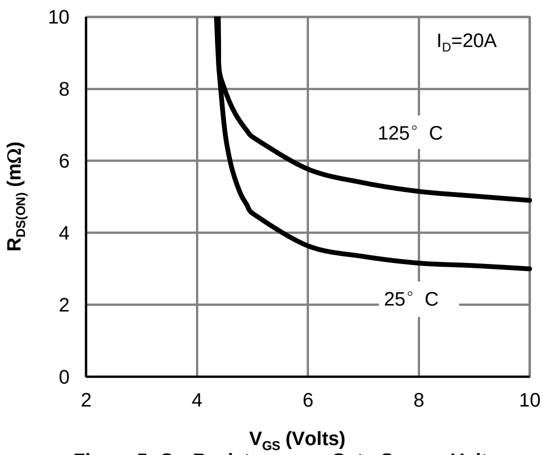


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

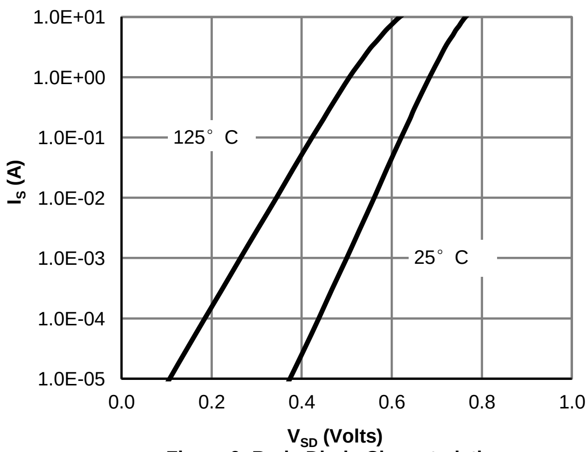


Figure 6: Body-Diode Characteristics (Note E)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

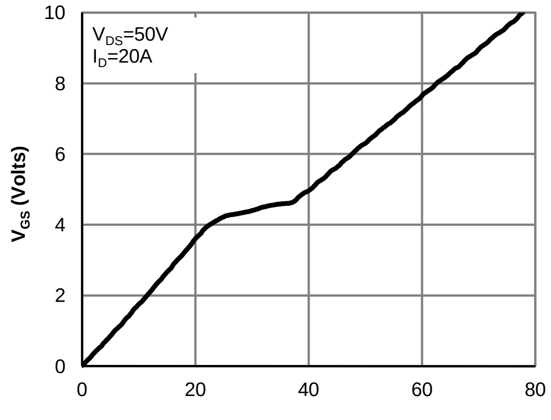


Figure 7: Gate-Charge Characteristics

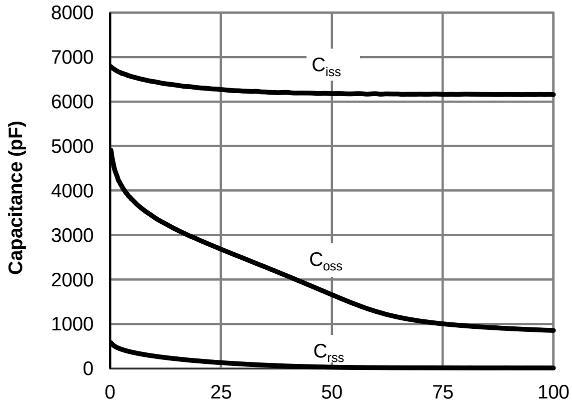
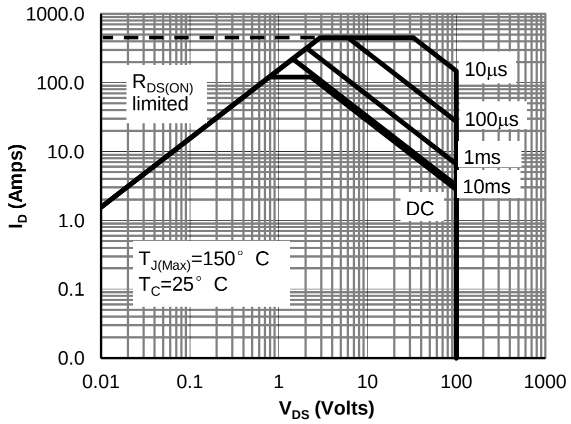


Figure 8: Capacitance Characteristics



V_{GS}> or equal to 6V
Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

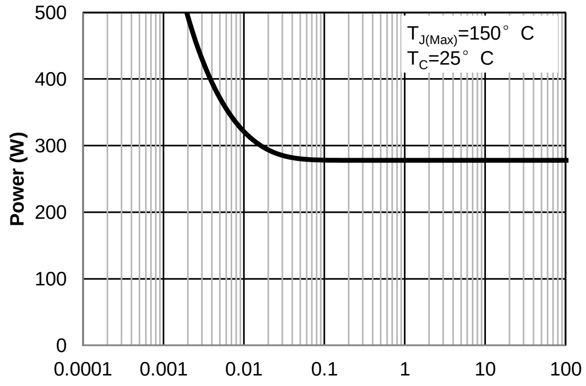


Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)

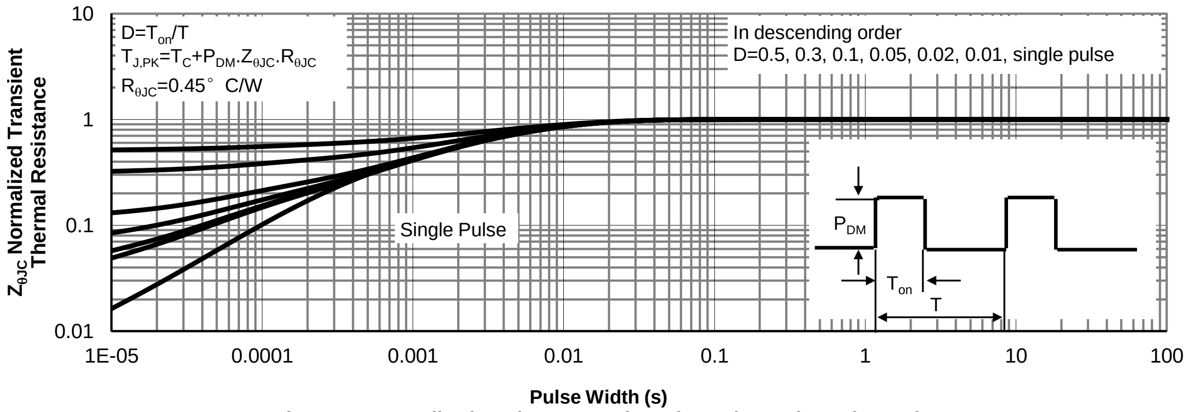


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

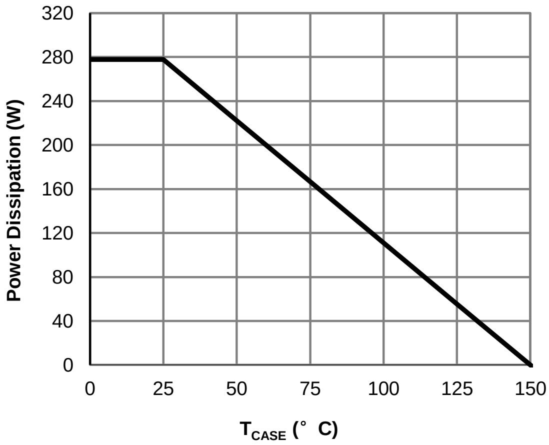


Figure 12: Power De-rating (Note F)

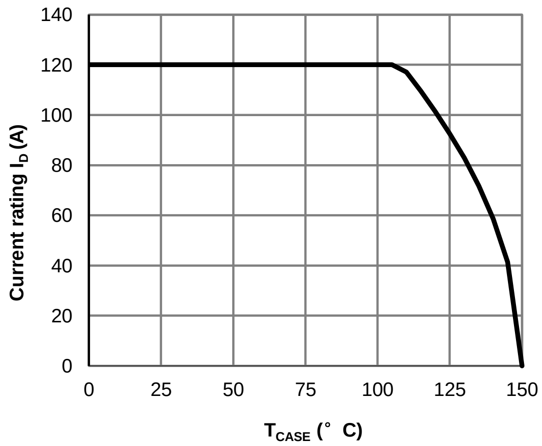


Figure 13: Current De-rating (Note F)

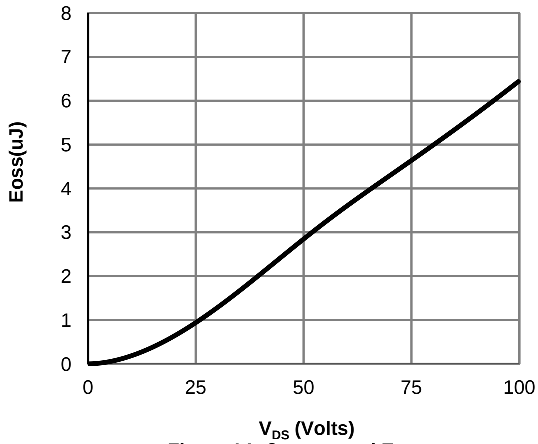


Figure 14: Coss stored Energy

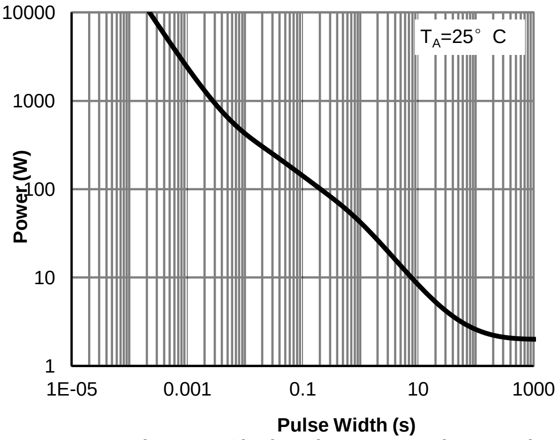


Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)

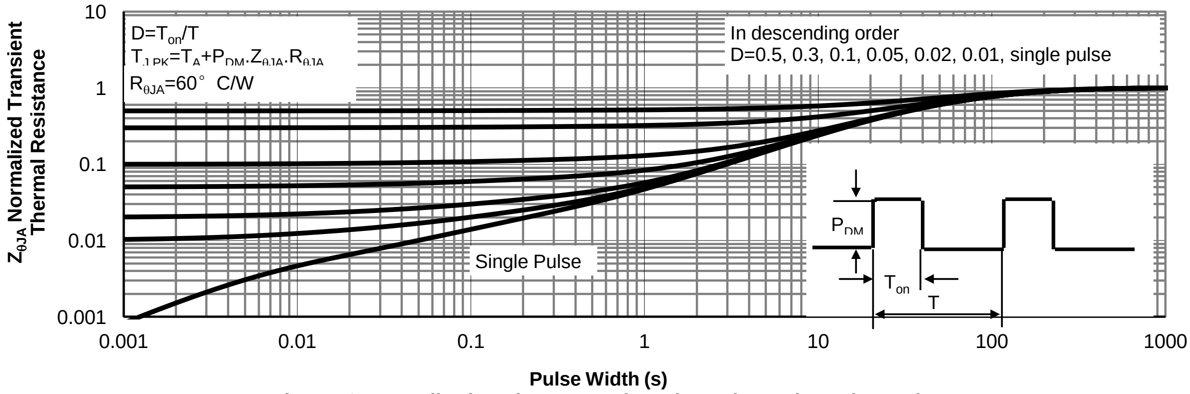


Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

Figure A: Gate Charge Test Circuit & Waveforms

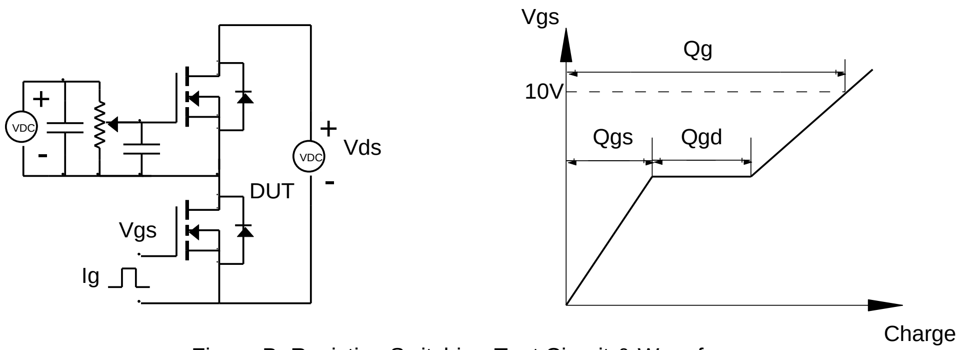


Figure B: Resistive Switching Test Circuit & Waveforms

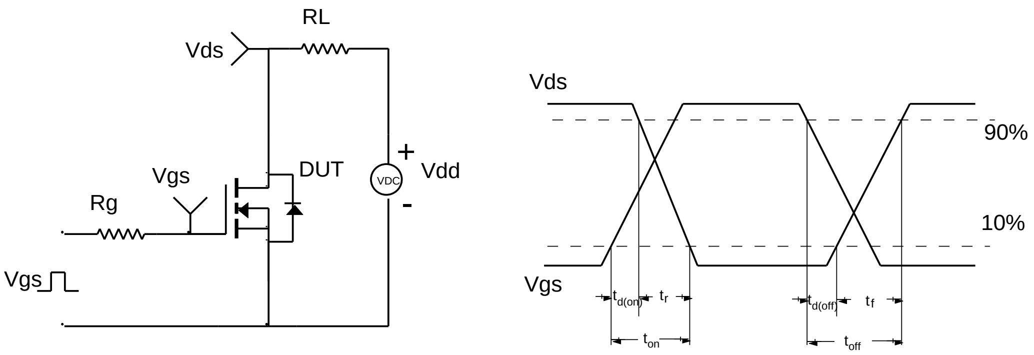


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

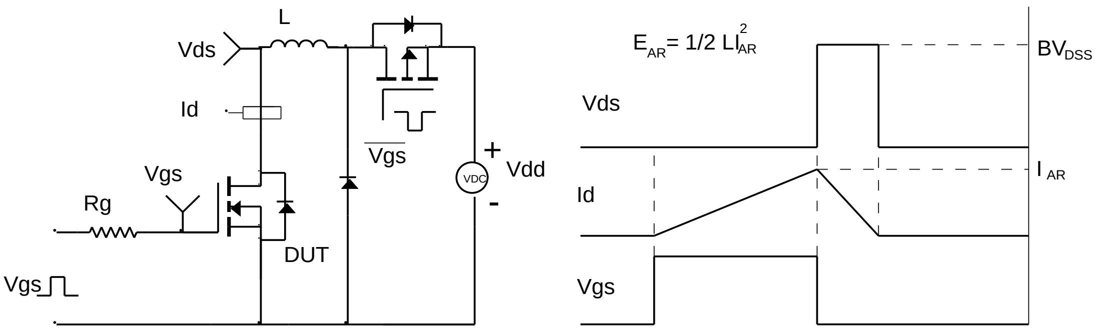


Figure D: Diode Recovery Test Circuit & Waveforms